Notic of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | HAN ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT D CUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0185537 A1	12-2002	Konda, Kazuhiko	235/462.01
	В	US-6,070,805 A	06-2000	Kaufman et al.	235/494
-	С	US-6,446,871 B1	09-2002	Buckley et al.	235/472.03
	D	US-6,694,333 B2	02-2004	Oldham, Don A.	707/104.1
	E	US-2001/0049734 A1	12-2001	Suwabe et al.	709/225
	F	US-			
	G	US-			
	H	US-			
	_	US-			
	7	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	P					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.